Se	arch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/807,327	ANDO, TAKASHI
Examiner	Art Unit
Monica Lewis	2822

	SEARCHED				
Class	Subclass	Date	Examiner		
257	295-300	12/10/2005	ML		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u> </u>				

SEARCH (INCLUDING SEAR)
	DATE	EXMR
EIC Search	12/10/2005	ML
East Search	12/10/2005	ML